

<b>L Number</b>	<b>Hits</b>	<b>Search Text</b>	<b>DB</b>	<b>Time stamp</b>
<b>37</b>	<b>7</b>	<b>((lower or top or bottom or upper or first or second) near substrate) near10 (bond or bonding or bonded) and pixel and ((test or testing or tested) near2 pad)</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:39</b>
<b>38</b>	<b>342</b>	<b>substrate.clm. and ((test or testing) near2 pad).clm.</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:39</b>
<b>39</b>	<b>9</b>	<b>substrate.clm. and ((test or testing) near2 pad).clm. and (data near pad).clm.</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:40</b>
<b>40</b>	<b>14</b>	<b>substrate.clm. and ((test or testing) near2 pad).clm. and (data near2 pad).clm.</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:40</b>
<b>41</b>	<b>4</b>	<b>substrate.clm. and ((test or testing) near2 pad).clm. and (data near2 pad).clm. and pixel.clm.</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:43</b>
<b>42</b>	<b>29</b>	<b>(data near pad) and (gate near pad) and ((test or testing) near2 pad)</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:43</b>
<b>43</b>	<b>26</b>	<b>(data near pad) same (gate near pad) and ((test or testing) near2 pad)</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:43</b>
<b>44</b>	<b>15</b>	<b>(data near pad) same (gate near pad) same ((test or testing) near2 pad)</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:44</b>
<b>45</b>	<b>6</b>	<b>(data near pad) same (gate near pad) same ((test or testing) near2 data near pad)</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:45</b>
<b>46</b>	<b>15</b>	<b>(data near pad) same (gate near pad) same ((test or testing) near2 pad)</b>	<b>USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB</b>	<b>2004/10/28 16:45</b>

47	5	(data near pad) same (gate near pad) same ((test or testing) near2 pad) and on/off	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:47
48	1	(data near2 on/off near2 (test or testing or tested) near2 pad)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:47
49	12	testing near2 data near2 pad	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:48
50	152	(test or testing) near2 data near2 pad	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:48
51	43	(test or testing) near data near pad	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:48
52	5	((test or testing) near data near pad) and ((test or testing) near gate near pad)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:51
53	4	((test or testing) near data near pad) and ((test or testing) near gate near pad) and (data adj pad)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/28 16:51